

Search Notes

Application/Control No.

09/747,370

Examiner

Hien Tran

Applicant(s)/Patent under
Reexamination

LABARGE ET AL.

Art Unit

1764

SEARCHED

Class	Subclass	Date	Examiner
422	177, 179, 180	6/23/2004	HT
updated	search	12/23/2004	HT
updated	search	3/13/06	HT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
iEast Image class/subclass search / Inventors' names search /text search	6/23/2004	HT
updated search	3/13/2006	HT